

<b>Notice of References Cited</b>	Application/Control No. 10/607,491	Applicant(s)/Patent Under Reexamination SHIN, CHANG-HYUN	
	Examiner HYDER ALI	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,360,708	03-2002	Hwang et al.	123/184.57
	B	US-6,634,334	10-2003	Hwang et al.	123/339.23
	C	US-4,922,879	05-1990	Kaji et al.	123/494
	D	US-5,564,387	10-1996	Igarashi et al.	123/339.23
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11082095 A	03-1999	Japan	KAWAI et al.	F02D 33/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.